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### **Embedded - System On Chip (SoC): The Heart of Modern Embedded Systems**

**Embedded - System On Chip (SoC)** refers to an integrated circuit that consolidates all the essential components of a computer system into a single chip. This includes a microprocessor, memory, and other peripherals, all packed into one compact and efficient package. SoCs are designed to provide a complete computing solution, optimizing both space and power consumption, making them ideal for a wide range of embedded applications.

### **What are Embedded - System On Chip (SoC)?**

**System On Chip (SoC)** integrates multiple functions of a computer or electronic system onto a single chip. Unlike traditional multi-chip solutions, SoCs combine a central

#### **Details**

Product Status	Active
Architecture	MCU, FPGA
Core Processor	ARM® Cortex®-M3
Flash Size	256KB
RAM Size	64KB
Peripherals	DDR, PCIe, SERDES
Connectivity	CANbus, Ethernet, I <sup>2</sup> C, SPI, UART/USART, USB
Speed	166MHz
Primary Attributes	FPGA - 50K Logic Modules
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	325-TFBGA, FCBGA
Supplier Device Package	325-FCBGA (11x11)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/microchip-technology/m2s050ts-1fcs325">https://www.e-xfl.com/product-detail/microchip-technology/m2s050ts-1fcs325</a>

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# 1 Revision History

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The revision history describes the changes that were implemented in the document. The changes are listed by revision, starting with the most current publication.

## 1.1 Revision 11.0

The following is a summary of the changes in revision 11.0 of this document.

- Updated [Table 24](#), page 22 with minimum and maximum values for input current low and high (SAR 73114 and 80314).
- Added [Non-Deterministic Random Bit Generator \(NRBG\) Characteristics](#), page 106 (SAR 73114 and 79517).
- Added 060 device in [Table 282](#), page 110 (SAR 79860).
- Added [DEVRST\\_N to Functional Times](#), page 116 (SAR 73114).
- Added [Cryptographic Block Characteristics](#), page 106 (SAR 73114 and 79516).
- Update [Table 296](#), page 121 with VTX-AMP details (SAR 81756).
- Update note in [Table 297](#), page 122 (SAR 74570 and 80677).
- Update [Table 298](#), page 122 with generic EPCS details (SAR 75307).
- Added [Table 308](#), page 129 (SAR 50424).

## 1.2 Revision 10.0

The following is a summary of the changes in revision 10.0 of this document.

- The Surge Current on VDD during DEVRST\_B Assertion and Surge Current on VDD during Digest Check using System Services tables were deleted and added reference to [AC393: Board Design Guidelines for SmartFusion2 SoC and IGLOO2 FPGAs Application Note](#). (SAR 76865 and 76623).
- Added 060 device in [Table 4](#), page 6 (SAR 76383).
- Updated [Table 24](#), page 22 for ramp time input (SAR 72103).
- Added 060 device details in [Table 284](#), page 112 (SAR 74927).
- Updated [Table 290](#), page 116 for name change (SAR 74925).
- Updated [Table 283](#), page 111 for 060 FG676 Package details (SAR 78849).
- Updated [Table 305](#), page 126 for SmartFusion2 and [Table 310](#), page 129 for IGLOO2 for SPI timing and Fmax (SAR 56645, 75331).
- Updated [Table 293](#), page 119 for Flash\*Freeze entry and exit times (SAR 75329, 75330).
- Updated [Table 297](#), page 122 for RX-CID information (SAR 78271).
- Added [Table 8](#), page 8 and [Figure 1](#), page 9 (SAR 78932).
- Updated [Table 223](#), page 76 for timing characteristics and [Table 224](#), page 77 (SAR 75998).
- Added [SRAM PUF](#), page 105 (SAR 64406).
- Added a footnote on digest cycle in [Table 5](#), page 7 (SAR 79812).

## 1.3 Revision 9.0

The following is a summary of the changes in revision 9.0 of this document.

- Added a note in [Table 5](#), page 7 (SAR 71506).
- Added a note in [Table 6](#), page 8 (SAR 74616).
- Added a note in [Figure 3](#), page 17 (SAR 71506).
- Updated Quiescent Supply Current for 060 in [Table 11](#), page 12 and [Table 12](#), page 13 (SAR 74483).
- Updated programming currents for 060 in [Table 13](#), page 13, [Table 14](#), page 13, and [Table 15](#), page 14.
- Added DEVRST\_B assertion tables (SAR 74708).
- Updated I/O speeds for LVDS 3.3 V in [Table 18](#), page 19 and [Table 21](#), page 20 (SAR 69829).
- Updated [Table 24](#), page 22 (SAR 69418).
- Updated [Table 25](#), page 22, [Table 26](#), page 23, [Table 27](#), page 23 (SAR 74570).
- Updated all AC/DC table to link to the [Input Capacitance, Leakage Current, and Ramp Time](#), page 22 for reference (SAR 69418).

**Table 128 • DDR2/SSTL18 Transmitter Characteristics (Output and Tristate Buffers)**

	$T_{DP}$		$T_{ZL}$		$T_{ZH}$		$T_{HZ}$		$T_{LZ}$		Unit
	-1	-Std									
<b>SSTL18 Class I (for DDRIO I/O Bank)</b>											
Single-ended	2.383	2.804	2.23	2.623	2.229	2.622	2.202	2.591	2.201	2.59	ns
Differential	2.413	2.84	2.797	3.29	2.797	3.29	2.282	2.685	2.282	2.685	ns
<b>SSTL18 Class II (for DDRIO I/O Bank)</b>											
Single-ended	2.281	2.683	2.196	2.584	2.195	2.583	2.171	2.555	2.17	2.554	ns
Differential	2.315	2.724	2.698	3.173	2.698	3.173	2.242	2.639	2.242	2.639	ns

### 2.3.6.5 Stub-Series Terminated Logic 1.5 V (SSTL15)

SSTL15 Class I and Class II are supported in IGLOO2 FPGAs and SmartFusion2 SoC FPGAs, and also comply with the reduced and full drive double data rate (DDR3) standard. IGLOO2 FPGA and SmartFusion2 SoC FPGA I/Os supports both standards for single-ended signaling and differential signaling for SSTL18. This standard requires a differential amplifier input buffer and a push-pull output buffer.

#### Minimum and Maximum DC/AC Input and Output Levels Specification

The following table lists the SSTL15 DC voltage specifications for DDRIO bank.

**Table 129 • SSTL15 DC Recommended DC Operating Conditions (for DDRIO I/O Bank Only)**

Parameter	Symbol	Min	Typ	Max	Unit
Supply voltage	$V_{DDI}$	1.425	1.5	1.575	V
Termination voltage	$V_{TT}$	0.698	0.750	0.803	V
Input reference voltage	$V_{REF}$	0.698	0.750	0.803	V

**Table 130 • SSTL15 DC Input Voltage Specification (for DDRIO I/O Bank Only)**

Parameter	Symbol	Min	Max	Unit
DC input logic high	$V_{IH}(DC)$	$V_{REF} + 0.1$	1.575	V
DC input logic low	$V_{IL}(DC)$	-0.3	$V_{REF} - 0.1$	V
Input current high <sup>1</sup>	$I_{IH}(DC)$			
Input current low <sup>1</sup>	$I_{IL}(DC)$			

1. See Table 24, page 22.

**Table 156 • LPDDR-LVCMOS 1.8 V AC Test Parameter Specifications**

Parameter	Symbol	Typ	Unit
Measuring/trip point for data path	$V_{TRIP}$	0.9	V
Resistance for enable path ( $T_{ZH}$ , $T_{ZL}$ , $T_{HZ}$ , $T_{LZ}$ )	$R_{ENT}$	2K	$\Omega$
Capacitive loading for enable path ( $T_{ZH}$ , $T_{ZL}$ , $T_{HZ}$ , $T_{LZ}$ )	$C_{ENT}$	5	pF
Capacitive loading for data path ( $T_{DP}$ )	$C_{LOAD}$	5	pF

**Table 157 • LPDDR-LVCMOS 1.8 V Mode Transmitter Drive Strength Specification for DDRIO Bank**

Output Drive Selection	$V_{OH}$ (V) Min	$V_{OL}$ (V) Max	$I_{OH}$ (at $V_{OH}$ ) mA	$I_{OL}$ (at $V_{OL}$ ) mA
2 mA	$V_{DDI} - 0.45$	0.45	2	2
4 mA	$V_{DDI} - 0.45$	0.45	4	4
6 mA	$V_{DDI} - 0.45$	0.45	6	6
8 mA	$V_{DDI} - 0.45$	0.45	8	8
10 mA	$V_{DDI} - 0.45$	0.45	10	10
12 mA	$V_{DDI} - 0.45$	0.45	12	12
16 mA <sup>1</sup>	$V_{DDI} - 0.45$	0.45	16	16

1. 16 mA Drive Strengths, All Slews, meet LPDDR JEDEC electrical compliance.

**Table 158 • LPDDR-LVCMOS 1.8V AC Switching Characteristics for Receiver (for DDRIO I/O Bank with Fixed Code - Input Buffers)**

ODT (On Die Termination)	-1	-Std	-1	-Std	Unit
None	1.968	2.315	2.099	2.47	ns

**Table 159 • LPDDR-LVCMOS 1.8 V AC Switching Characteristics for Transmitter for DDRIO I/O Bank (Output and Tristate Buffers)**

Output Drive Selection	Slew Control	$T_{DP}$		$T_{ZL}$		$T_{ZH}$		$T_{HZ}^1$		$T_{LZ}^1$		Unit
		-1	-Std	-1	-Std	-1	-Std	-1	-Std	-1	-Std	
2 mA	slow	4.234	4.981	3.646	4.29	4.245	4.995	4.908	5.774	4.434	5.216	ns
	medium	3.824	4.498	3.282	3.861	3.834	4.511	4.625	5.441	4.116	4.843	ns
	medium_fast	3.627	4.267	3.111	3.66	3.637	4.279	4.481	5.272	3.984	4.687	ns
	fast	3.605	4.241	3.097	3.644	3.615	4.253	4.472	5.262	3.973	4.674	ns
4 mA	slow	3.923	4.615	3.314	3.9	3.918	4.61	5.403	6.356	4.894	5.757	ns
	medium	3.518	4.138	2.961	3.484	3.515	4.135	5.121	6.025	4.561	5.366	ns
	medium_fast	3.321	3.907	2.783	3.275	3.317	3.903	4.966	5.843	4.426	5.206	ns
	fast	3.301	3.883	2.77	3.259	3.296	3.878	4.957	5.831	4.417	5.196	ns
6 mA	slow	3.71	4.364	3.104	3.652	3.702	4.355	5.62	6.612	5.08	5.977	ns
	medium	3.333	3.921	2.779	3.27	3.325	3.913	5.346	6.289	4.777	5.62	ns
	medium_fast	3.155	3.712	2.62	3.083	3.146	3.702	5.21	6.13	4.657	5.479	ns
	fast	3.134	3.688	2.608	3.068	3.125	3.677	5.202	6.12	4.648	5.468	ns
8 mA	slow	3.619	4.258	3.007	3.538	3.607	4.244	5.815	6.841	5.249	6.175	ns

### 2.3.7.5 RSDS

Reduced Swing Differential Signaling (RSDS) is similar to an LVDS high-speed interface using differential signaling. RSDS has a similar implementation to LVDS devices and is only intended for point-to-point applications.

#### Minimum and Maximum Input and Output Levels

**Table 203 • RSDS Recommended DC Operating Conditions**

Parameter	Symbol	Min	Typ	Max	Unit
Supply voltage	$V_{DDI}$	2.375	2.5	2.625	V

**Table 204 • RSDS DC Input Voltage Specification**

Parameter	Symbol	Min	Max	Unit
DC input voltage	$V_I$	0	2.925	V

**Table 205 • RSDS DC Output Voltage Specification**

Parameter	Symbol	Min	Typ	Max	Unit
DC output logic high	$V_{OH}$	1.25	1.425	1.6	V
DC output logic low	$V_{OL}$	0.9	1.075	1.25	V

**Table 206 • RSDS Differential Voltage Specification**

Parameter	Symbol	Min	Max	Unit
Differential output voltage swing	$V_{OD}$	100	600	mV
Output common mode voltage	$V_{OCM}$	0.5	1.5	V
Input common mode voltage	$V_{ICM}$	0.3	1.5	V
Input differential voltage	$V_{ID}$	100	600	mV

**Table 207 • RSDS Minimum and Maximum AC Switching Speed**

Parameter	Symbol	Max	Unit	Conditions
Maximum data rate (for MSIO I/O bank)	$D_{MAX}$	520	Mbps	AC loading: 2 pF / 100 $\Omega$ differential load
Maximum data rate (for MSIOD I/O bank)	$D_{MAX}$	700	Mbps	AC loading: 2 pF / 100 $\Omega$ differential load

**Table 208 • RSDS AC Impedance Specifications**

Parameter	Symbol	Typ	Unit
Termination resistance	RT	100	$\Omega$

**Table 209 • RSDS AC Test Parameter Specifications**

Parameter	Symbol	Typ	Unit
Measuring/trip point for data path	$V_{TRIP}$	Cross point	V
Resistance for enable path ( $T_{ZH}$ , $T_{ZL}$ , $T_{HZ}$ , $T_{LZ}$ )	$R_{ENT}$	2K	$\Omega$
Capacitive loading for enable path ( $T_{ZH}$ , $T_{ZL}$ , $T_{HZ}$ , $T_{LZ}$ )	$C_{ENT}$	5	pF

**Table 215 • LVPECL DC Input Voltage Specification**

Parameter	Symbol	Min	Max	Unit
DC input voltage	$V_I$	0	3.45	V

**Table 216 • LVPECL DC Differential Voltage Specification**

Parameter	Symbol	Min	Typ	Max	Unit
Input common mode voltage	$V_{ICM}$	0.3		2.8	V
Input differential voltage	$V_{IDIFF}$	100	300	1,000	mV

**Table 217 • LVPECL Minimum and Maximum AC Switching Speeds**

Parameter	Symbol	Max	Unit
Maximum data rate	$D_{MAX}$	900	Mbps

**AC Switching Characteristics**

Worst commercial-case conditions:  $T_J = 85\text{ }^\circ\text{C}$ ,  $V_{DD} = 1.14\text{ V}$ ,  $V_{DDI} = 2.375\text{ V}$ .

**Table 218 • LVPECL Receiver Characteristics for MSIO I/O Bank**

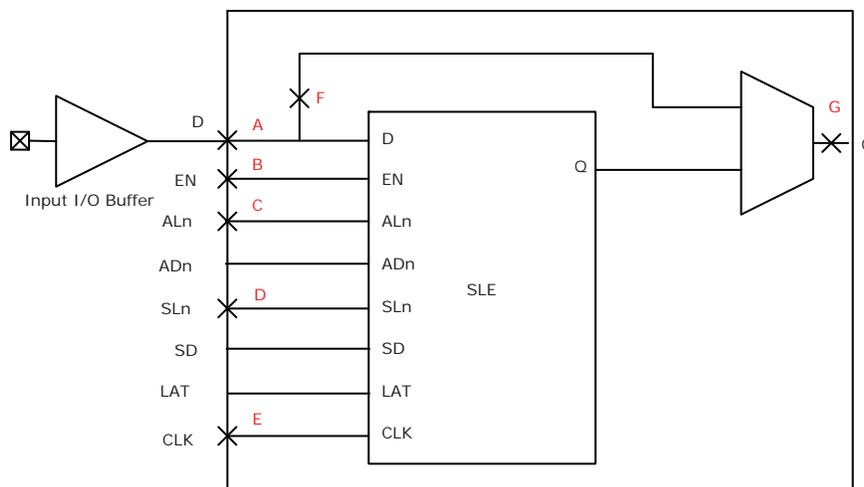
On-Die Termination (ODT)	$T_{PY}$		Unit
	-1	-Std	
None	2.572	3.025	ns
100	2.569	3.023	ns

**2.3.8 I/O Register Specifications**

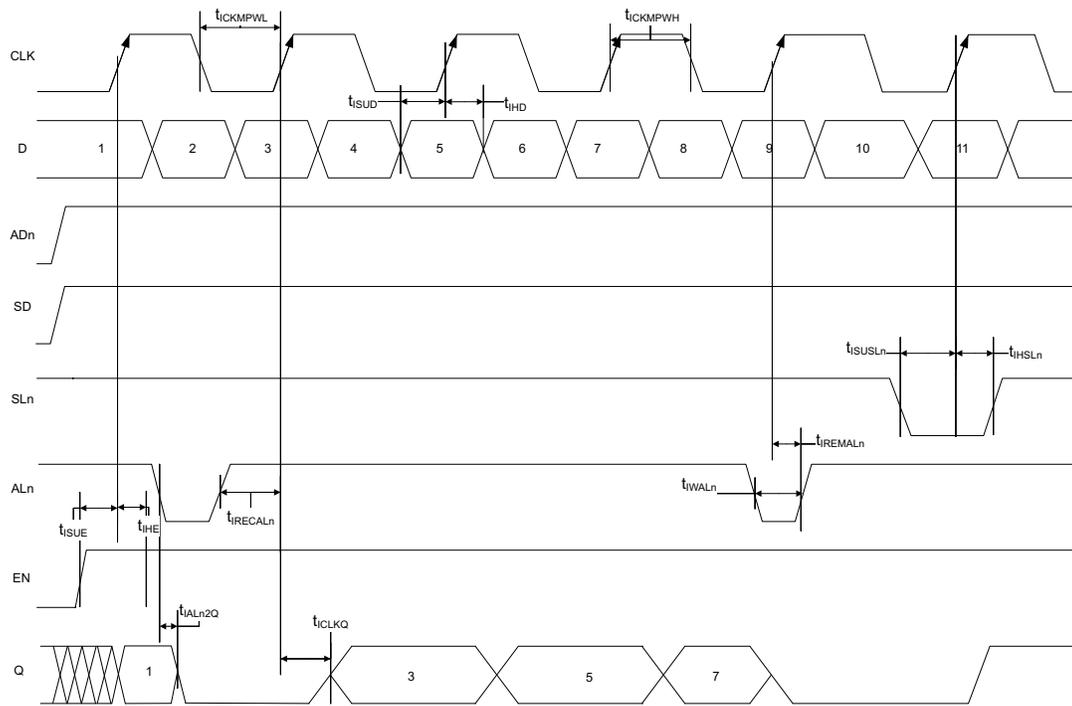
This section describes input and output register specifications.

**2.3.8.1 Input Register**

**Figure 6 • Timing Model for Input Register**



**Figure 7 • I/O Register Input Timing Diagram**

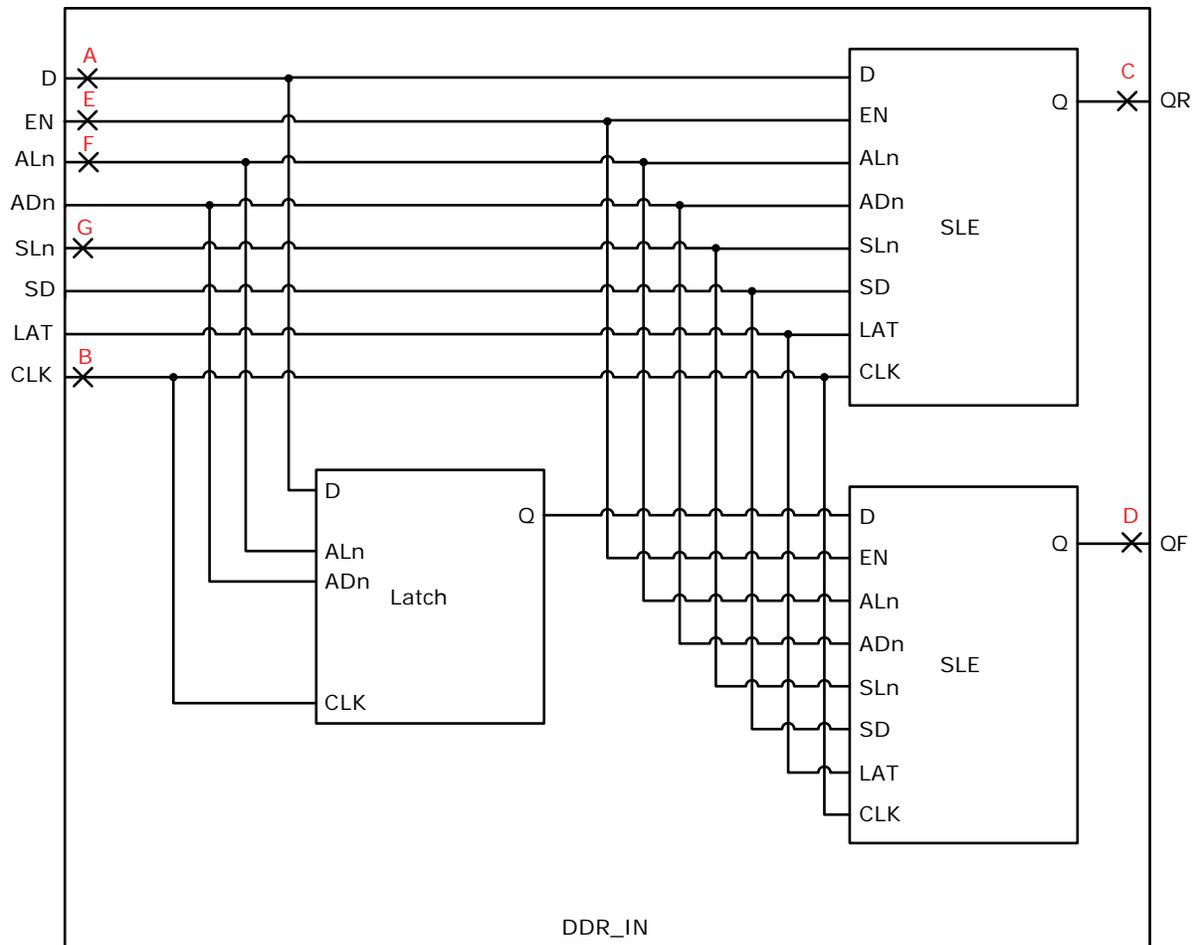


### 2.3.9 DDR Module Specification

This section describes input and output DDR module and timing specifications.

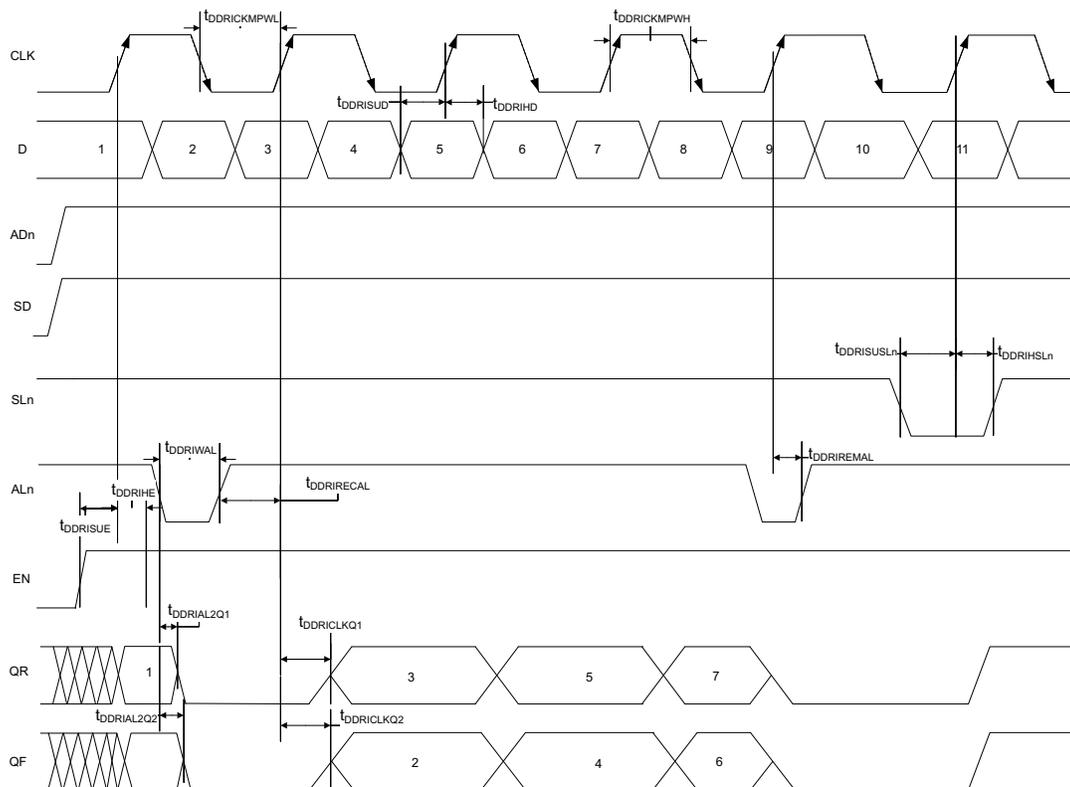
#### 2.3.9.1 Input DDR Module

Figure 10 • Input DDR Module



### 2.3.9.2 Input DDR Timing Diagram

Figure 11 • Input DDR Timing Diagram



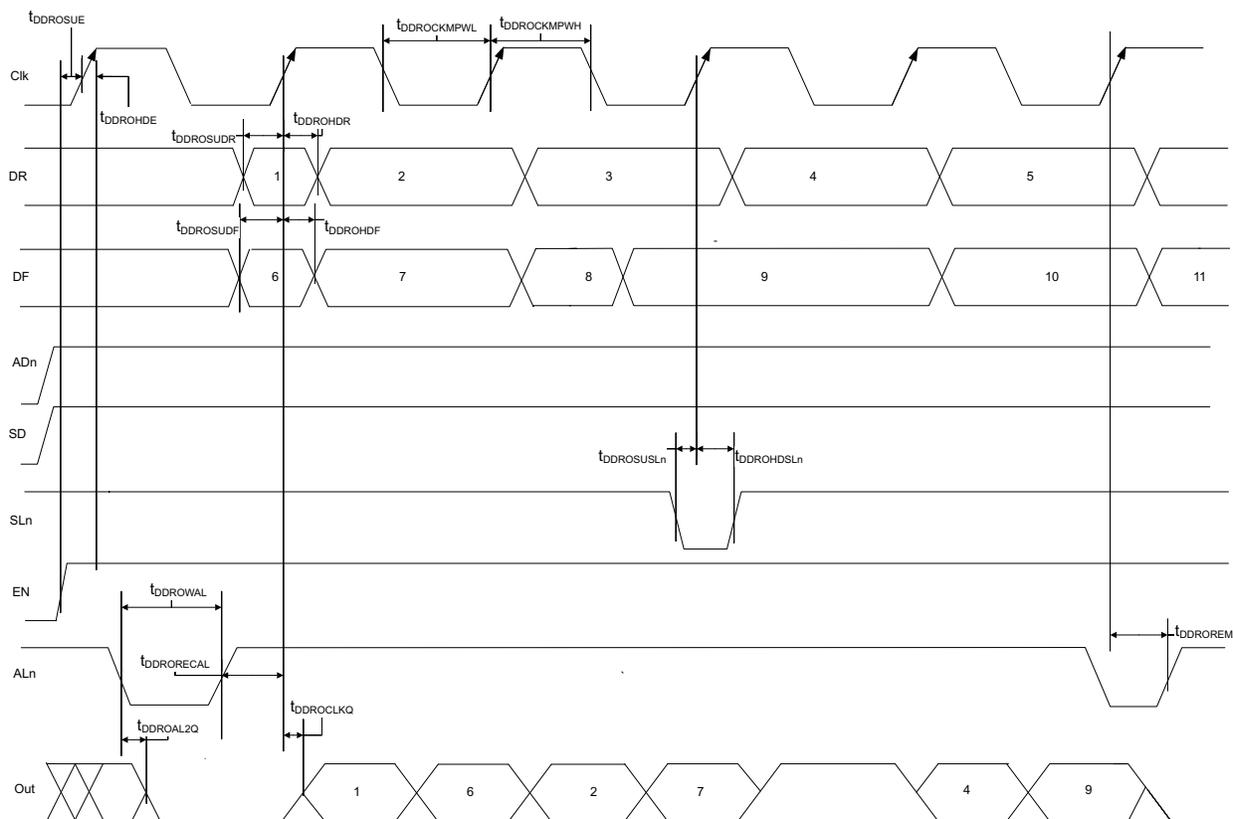
### 2.3.9.3 Timing Characteristics

The following table lists the input DDR propagation delays in worst commercial-case conditions when  $T_J = 85^\circ\text{C}$ ,  $V_{DD} = 1.14\text{ V}$ .

Table 221 • Input DDR Propagation Delays

Symbol	Description	Measuring Nodes (from, to)	-1	-Std	Unit
$T_{DDRICKLKQ1}$	Clock-to-Out Out_QR for input DDR	B, C	0.16	0.188	ns
$T_{DDRICKLKQ2}$	Clock-to-Out Out_QF for input DDR	B, D	0.166	0.195	ns
$T_{DDRISUD}$	Data setup for input DDR	A, B	0.357	0.421	ns
$T_{DDRIHD}$	Data hold for input DDR	A, B	0	0	ns
$T_{DDRISUE}$	Enable setup for input DDR	E, B	0.46	0.542	ns
$T_{DDRIHE}$	Enable hold for input DDR	E, B	0	0	ns
$T_{DDRISUSL}$	Synchronous load setup for input DDR	G, B	0.46	0.542	ns
$T_{DDRIHSL}$	Synchronous load hold for input DDR	G, B	0	0	ns
$T_{DDRIR2Q1}$	Asynchronous load-to-out QR for input DDR	F, C	0.587	0.69	ns
$T_{DDRIR2Q2}$	Asynchronous load-to-out QF for input DDR	F, D	0.541	0.636	ns
$T_{DDRIREMAL}$	Asynchronous load removal time for input DDR	F, B	0	0	ns
$T_{DDRIRECAL}$	Asynchronous load recovery time for input DDR	F, B	0.074	0.087	ns

**Figure 13 • Output DDR Timing Diagram**



**2.3.9.5 Timing Characteristics**

The following table lists the output DDR propagation delays in worst commercial-case conditions when  $T_J = 85^\circ\text{C}$ ,  $V_{DD} = 1.14\text{ V}$ .

**Table 222 • Output DDR Propagation Delays**

Symbol	Description	Measuring Nodes (from, to)	-1	-Std	Unit
$T_{DDROCLKQ}$	Clock-to-out of DDR for output DDR	E, G	0.263	0.309	ns
$T_{DDROSUDF}$	Data_F data setup for output DDR	F, E	0.143	0.168	ns
$T_{DDROSUDR}$	Data_R data setup for output DDR	A, E	0.19	0.223	ns
$T_{DDROHDF}$	Data_F data hold for output DDR	F, E	0	0	ns
$T_{DDROHDR}$	Data_R data hold for output DDR	A, E	0	0	ns
$T_{DDROSUE}$	Enable setup for input DDR	B, E	0.419	0.493	ns
$T_{DDROHE}$	Enable hold for input DDR	B, E	0	0	ns
$T_{DDROSUSLn}$	Synchronous load setup for input DDR	D, E	0.196	0.231	ns
$T_{DDROHSLn}$	Synchronous load hold for input DDR	D, E	0	0	ns
$T_{DDROAL2Q}$	Asynchronous load-to-out for output DDR	C, G	0.528	0.621	ns
$T_{DDROREMA}$	Asynchronous load removal time for output DDR	C, E	0	0	ns
$T_{DDRORECAL}$	Asynchronous load recovery time for output DDR	C, E	0.034	0.04	ns

The following table lists the RAM1K18 – two-port mode for depth × width configuration 512 × 36 in worst commercial-case conditions when  $T_J = 85\text{ }^\circ\text{C}$ ,  $V_{DD} = 1.14\text{ V}$ .

**Table 236 • RAM1K18 – Two-Port Mode for Depth × Width Configuration 512 × 36**

Parameter	Symbol	–1		–Std		Unit
		Min	Max	Min	Max	
Clock period	$T_{CY}$	2.5		2.941		ns
Clock minimum pulse width high	$T_{CLKMPWH}$	1.125		1.323		ns
Clock minimum pulse width low	$T_{CLKMPWL}$	1.125		1.323		ns
Pipelined clock period	$T_{PLCY}$	2.5		2.941		ns
Pipelined clock minimum pulse width high	$T_{PLCLKMPWH}$	1.125		1.323		ns
Pipelined clock minimum pulse width low	$T_{PLCLKMPWL}$	1.125		1.323		ns
Read access time with pipeline register	$T_{CLK2Q}$		0.334		0.393	ns
Read access time without pipeline register			2.25		2.647	ns
Address setup time	$T_{ADDRSU}$	0.313		0.368		ns
Address hold time	$T_{ADDRHD}$	0.274		0.322		ns
Data setup time	$T_{DSU}$	0.337		0.396		ns
Data hold time	$T_{DHD}$	0.111		0.13		ns
Block select setup time	$T_{BLKSU}$	0.207		0.244		ns
Block select hold time	$T_{BLKHD}$	0.201		0.237		ns
Block select to out disable time (when pipelined register is disabled)	$T_{BLK2Q}$		2.25		2.647	ns
Block select minimum pulse width	$T_{BLKMPW}$	0.186		0.219		ns
Read enable setup time	$T_{RDESU}$	0.449		0.528		ns
Read enable hold time	$T_{RDEHD}$	0.167		0.197		ns
Pipelined read enable setup time (A_DOUT_EN, B_DOUT_EN)	$T_{RDPLESU}$	0.248		0.291		ns
Pipelined read enable hold time (A_DOUT_EN, B_DOUT_EN)	$T_{RDPLEHD}$	0.102		0.12		ns
Asynchronous reset to output propagation delay	$T_{R2Q}$		1.506		1.772	ns
Asynchronous reset removal time	$T_{RSTREM}$	0.506		0.595		ns
Asynchronous reset recovery time	$T_{RSTREC}$	0.004		0.005		ns
Asynchronous reset minimum pulse width	$T_{RSTMPW}$	0.301		0.354		ns
Pipelined register asynchronous reset removal time	$T_{PLRSTREM}$	–0.279		–0.328		ns
Pipelined register asynchronous reset recovery time	$T_{PLRSTREC}$	0.327		0.385		ns
Pipelined register asynchronous reset minimum pulse width	$T_{PLRSTMPW}$	0.282		0.332		ns
Synchronous reset setup time	$T_{SRSTSU}$	0.226		0.265		ns
Synchronous reset hold time	$T_{SRSTHD}$	0.036		0.043		ns
Write enable setup time	$T_{WESU}$	0.39		0.458		ns
Write enable hold time	$T_{WEHD}$	0.242		0.285		ns
Maximum frequency	$F_{MAX}$		400		340	MHz

### 2.3.12.2 FPGA Fabric Micro SRAM ( $\mu$ SRAM)

The following table lists the  $\mu$ SRAM in  $64 \times 18$  mode in worst commercial-case conditions when  $T_J = 85^\circ\text{C}$ ,  $V_{DD} = 1.14\text{ V}$ .

**Table 237 •  $\mu$ SRAM (RAM64x18) in  $64 \times 18$  Mode**

Parameter	Symbol	-1		-Std		Unit
		Min	Max	Min	Max	
Read clock period	$T_{CY}$	4		4		ns
Read clock minimum pulse width high	$T_{CLKMPWH}$	1.8		1.8		ns
Read clock minimum pulse width low	$T_{CLKMPWL}$	1.8		1.8		ns
Read pipeline clock period	$T_{PLCY}$	4		4		ns
Read pipeline clock minimum pulse width high	$T_{PLCLKMPWH}$	1.8		1.8		ns
Read pipeline clock minimum pulse width low	$T_{PLCLKMPWL}$	1.8		1.8		ns
Read access time with pipeline register	$T_{CLK2Q}$		0.266		0.313	ns
Read access time without pipeline register			1.677		1.973	ns
Read address setup time in synchronous mode	$T_{ADDRSU}$	0.301		0.354		ns
Read address setup time in asynchronous mode			1.856		2.184	ns
Read address hold time in synchronous mode	$T_{ADDRHD}$	0.091		0.107		ns
Read address hold time in asynchronous mode			-0.778		-0.915	ns
Read enable setup time	$T_{RDENSU}$	0.278		0.327		ns
Read enable hold time	$T_{RDENHD}$	0.057		0.067		ns
Read block select setup time	$T_{BLKSU}$	1.839		2.163		ns
Read block select hold time	$T_{BLKHD}$	-0.65		-0.765		ns
Read block select to out disable time (when pipelined register is disabled)	$T_{BLK2Q}$		2.036		2.396	ns
Read asynchronous reset removal time (pipelined clock)	$T_{RSTREM}$	-0.023		-0.027		ns
Read asynchronous reset removal time (non-pipelined clock)			0.046		0.054	ns
Read asynchronous reset recovery time (pipelined clock)	$T_{RSTREC}$	0.507		0.597		ns
Read asynchronous reset recovery time (non-pipelined clock)			0.236		0.278	ns
Read asynchronous reset to output propagation delay (with pipelined register enabled)	$T_{R2Q}$		0.839		0.987	ns
Read synchronous reset setup time	$T_{SRSTSU}$	0.271		0.319		ns
Read synchronous reset hold time	$T_{SRSTHD}$	0.061		0.071		ns
Write clock period	$T_{CCY}$	4		4		ns
Write clock minimum pulse width high	$T_{CCLKMPWH}$	1.8		1.8		ns
Write clock minimum pulse width low	$T_{CCLKMPWL}$	1.8		1.8		ns
Write block setup time	$T_{BLKCSU}$	0.404		0.476		ns
Write block hold time	$T_{BLKCHD}$	0.007		0.008		ns
Write input data setup time	$T_{DINCSU}$	0.115		0.135		ns
Write input data hold time	$T_{DINCHD}$	0.15		0.177		ns

**Table 242 •  $\mu$ SRAM (RAM512x2) in 512 x 2 Mode (continued)**

Parameter	Symbol	-1		-Std		Unit
		Min	Max	Min	Max	
Write clock period	$T_{CCY}$	4		4		ns
Write clock minimum pulse width high	$T_{CCLKMPWH}$	1.8		1.8		ns
Write clock minimum pulse width low	$T_{CCLKMPWL}$	1.8		1.8		ns
Write block setup time	$T_{BLKCSU}$	0.404		0.476		ns
Write block hold time	$T_{BLKCHD}$	0.007		0.008		ns
Write input data setup time	$T_{DINCSU}$	0.101		0.118		ns
Write input data hold time	$T_{DINCHD}$	0.137		0.161		ns
Write address setup time	$T_{ADDRCSU}$	0.088		0.104		ns
Write address hold time	$T_{ADDRCHD}$	0.247		0.29		ns
Write enable setup time	$T_{WECSU}$	0.397		0.467		ns
Write enable hold time	$T_{WECHD}$	-0.03		-0.03		ns
Maximum frequency	$F_{MAX}$		250		250	MHz

The following table lists the  $\mu$ SRAM in 1024 x 1 mode in worst commercial-case conditions when  $T_J = 85^\circ\text{C}$ ,  $V_{DD} = 1.14\text{ V}$ .

**Table 243 •  $\mu$ SRAM (RAM1024x1) in 1024 x 1 Mode**

Parameter	Symbol	-1		-Std		Unit
		Min	Max	Min	Max	
Read clock period	$T_{CY}$	4		4		ns
Read clock minimum pulse width high	$T_{CLKMPWH}$	1.8		1.8		ns
Read clock minimum pulse width low	$T_{CLKMPWL}$	1.8		1.8		ns
Read pipeline clock period	$T_{PLCY}$	4		4		ns
Read pipeline clock minimum pulse width high	$T_{PLCLKMPWH}$	1.8		1.8		ns
Read pipeline clock minimum pulse width low	$T_{PLCLKMPWL}$	1.8		1.8		ns
Read access time with pipeline register	$T_{CLK2Q}$		0.27		0.31	ns
Read access time without pipeline register				1.78		2.1
Read address setup time in synchronous mode	$T_{ADDRSU}$	0.301		0.354		ns
Read address setup time in asynchronous mode			1.978		2.327	
Read address hold time in synchronous mode	$T_{ADDRHD}$	0.137		0.161		ns
Read address hold time in asynchronous mode			-0.6		-0.71	
Read enable setup time	$T_{RDENSU}$	0.278		0.327		ns
Read enable hold time	$T_{RDENHD}$	0.057		0.067		ns
Read block select setup time	$T_{BLKSU}$	1.839		2.163		ns
Read block select hold time	$T_{BLKHHD}$	-0.65		-0.77		ns
Read block select to out disable time (when pipelined register is disabled)	$T_{BLK2Q}$		2.16		2.54	ns
Read asynchronous reset removal time (pipelined clock)	$T_{RSTREM}$	-0.02		-0.03		ns
Read asynchronous reset removal time (non-pipelined clock)			0.046		0.054	

**Table 251 • SmartFusion2 Cortex-M3 ISP Programming (eNVM Only) (continued)**

M2S/M2GL Device	Image size Bytes	Authenticate	Program	Verify	Unit
150	544496	10	158	15	Sec

**Table 252 • SmartFusion2 Cortex-M3 ISP Programming (Fabric and eNVM)**

M2S/M2GL Device	Image size Bytes	Authenticate	Program	Verify	Unit
005	439296	9	61	11	Sec
010	842688	15	107	21	Sec
025	1497408	26	121	35	Sec
050	2695168	43	141	55	Sec
060	2686464	48	143	60	Sec
090	4190208	75	244	91	Sec
150	6682768	117	296	141	Sec

**Table 253 • Programming Times with 100 kHz, 25 MHz, and 12.5 MHz SPI Clock Rates (Fabric Only)**

M2S/M2GL Device	Auto Programming	Auto Update	Programming Recovery	Unit
	100 kHz	25 MHz	12.5 MHz	
005	47	27	28	Sec
010	77	35	35	Sec
025	150	42	41	Sec
050	33 <sup>1</sup>	Not Supported	Not Supported	Sec
060	291	83	82	Sec
090	427	109	108	Sec
150	708	157	160	Sec

1. Auto Programming in 050 device is done through SC\_SPI, and SPI CLK is set to 6.25 MHz.

**Table 254 • Programming Times with 100 kHz, 25 MHz, and 12.5 MHz SPI Clock Rates (eNVM Only)**

M2S/M2GL Device	Auto Programming	Auto Update	Programming Recovery	Unit
	100 kHz	25 MHz	12.5 MHz	
005	41	48	49	Sec
010	86	87	87	Sec
025	87	85	86	Sec
050	85	Not Supported	Not Supported	Sec
060	78	86	86	Sec
090	154	162	162	Sec

## 2.3.14 Math Block Timing Characteristics

The fundamental building block in any digital signal processing algorithm is the multiply-accumulate function. Each IGLOO2 and SmartFusion2 SoC math block supports 18×18 signed multiplication, dot product, and built-in addition, subtraction, and accumulation units to combine multiplication results efficiently. The following table lists the math blocks with all registers used in worst commercial-case conditions when  $T_J = 85\text{ }^\circ\text{C}$ ,  $V_{DD} = 1.14\text{ V}$ .

**Table 268 • Math Blocks with all Registers Used**

Parameter	Symbol	-1		-Std		Unit
		Min	Max	Min	Max	
Input, control register setup time	$T_{MISU}$	0.149		0.176		ns
Input, control register hold time	$T_{MIHD}$	1.68		1.976		ns
CDIN input setup time	$T_{MOCDINSU}$	0.185		0.218		ns
CDIN input hold time	$T_{MOCDINHHD}$	0.08		0.094		ns
Synchronous reset/enable setup time	$T_{MSRSTENSU}$	-0.419		-0.493		ns
Synchronous reset/enable hold time	$T_{MSRSTENHD}$	0.011		0.013		ns
Asynchronous reset removal time	$T_{MARSTREM}$	0		0		ns
Asynchronous reset recovery time	$T_{MARSTREC}$	0.088		0.104		ns
Output register clock to out delay	$T_{MOCQ}$		0.232		0.273	ns
CLK minimum period	$T_{MCLKMP}$	2.245		2.641		ns

The following table lists the math blocks with input bypassed and output registers used in worst commercial-case conditions when  $T_J = 85\text{ }^\circ\text{C}$ ,  $V_{DD} = 1.14\text{ V}$ .

**Table 269 • Math Block with Input Bypassed and Output Registers Used**

Parameter	Symbol	-1		-Std		Unit
		Min	Max	Min	Max	
Output register setup time	$T_{MOSU}$	2.294		2.699		ns
Output register hold time	$T_{MOHD}$	1.68		1.976		ns
CDIN input setup time	$T_{MOCDINSU}$	0.115		0.136		ns
CDIN input hold time	$T_{MOCDINHHD}$	-0.444		-0.522		ns
Synchronous reset/enable setup time	$T_{MSRSTENSU}$	-0.419		-0.493		ns
Synchronous reset/enable hold time	$T_{MSRSTENHD}$	0.011		0.013		ns
Asynchronous reset removal time	$T_{MARSTREM}$	0		0		ns
Asynchronous reset recovery time	$T_{MARSTREC}$	0.014		0.017		ns
Output register clock to out delay	$T_{MOCQ}$		0.232		0.273	ns
CLK minimum period	$T_{MCLKMP}$	2.179		2.563		ns

1. The minimum output clock frequency is limited by the PLL. For more information, see [UG0449: SmartFusion2 and IGLOO2 Clocking Resources User Guide](#).
2. The PLL is used in conjunction with the Clock Conditioning Circuitry. Performance is limited by the CCC output frequency.

The following table lists the CCC/PLL jitter specifications in worst-case industrial conditions when  $T_J = 100\text{ }^\circ\text{C}$ ,  $V_{DD} = 1.14\text{ V}$ .

**Table 283 • IGLOO2 and SmartFusion2 SoC FPGAs CCC/PLL Jitter Specifications**

CCC Output Maximum Peak-to-Peak Period Jitter $F_{OUT\_CCC}$						
Parameter	Conditions/Package Combinations				Unit	
<b>10 FG484, 050 FG896/FG484/FCS325 Packages<sup>1</sup></b>	SSO = 0	$0 < SSO \leq 2$	$SSO \leq 4$	$SSO \leq 8$	$SSO \leq 16$	
20 MHz to 100 MHz	$\text{Max}(110, \pm 1\% \times (1/F_{OUT\_CCC}))$	$\text{Max}(150, \pm 1\% \times (1/F_{OUT\_CCC}))$				ps
100 MHz to 400 MHz	$\text{Max}(120, \pm 1\% \times (1/F_{OUT\_CCC}))$	$\text{Max}(150, \pm 1\% \times (1/F_{OUT\_CCC}))$		$\text{Max}(170, \pm 1\% \times (1/F_{OUT\_CCC}))$		ps
<b>025 FG484/FCS325 Package<sup>1</sup></b>	$0 < SSO \leq 16$					
20 MHz to 74 MHz	$\pm 1\% \times (1/F_{OUT\_CCC})$					ps
74 MHz to 400 MHz	210					ps
<b>005 FG484 Package<sup>1</sup></b>	$0 < SSO \leq 16$					
20 MHz to 53 MHz	$\pm 1\% \times (1/F_{OUT\_CCC})$					ps
53 MHz to 400 MHz	270					ps
<b>090 FG676 and FC325 Package<sup>1</sup></b>	$0 < SSO \leq 16$					
20 MHz to 100 MHz	$\pm 1\% \times (1/F_{OUT\_CCC})$					ps
100 MHz to 400 MHz	150					ps
<b>060 FG676 Package<sup>1</sup></b>	$0 < SSO \leq 16$					
20 MHz to 100 MHz	$\pm 1\% \times (1/F_{OUT\_CCC})$					ps
100 MHz to 400 MHz	150					ps
<b>150 FC1152 Package<sup>1</sup></b>	$0 < SSO \leq 16$					
20 MHz to 100 MHz	$\pm 1\% \times (1/F_{OUT\_CCC})$					ps
100 MHz to 400 MHz	120					ps

1. SSO data is based on LVCMOS 2.5 V MSIO and/or MSIOD bank I/Os.

## 2.3.24 Power-up to Functional Times

The following table lists the SmartFusion2 power-up to functional times in worst-case industrial conditions when  $T_J = 100\text{ }^\circ\text{C}$ ,  $V_{DD} = 1.14\text{ V}$ .

**Table 288 • Power-up to Functional Times for SmartFusion2**

Symbol	From	To	Description	Maximum Power-up to Functional Time for SmartFusion2 (uS)						
				005	010	025	050	060	090	150
$T_{POR2OUT}$	POWER_ON_RESET_N	Output available at I/O	Fabric to output	647	500	531	483	474	524	647
$T_{POR2MSSRST}$	POWER_ON_RESET_N	MSS_RESE T_N_M2F	Fabric to MSS	644	497	528	480	468	518	641
$T_{MSSRST2OUT}$	MSS_RESET_N_M2F	Output available at I/O	MSS to output	3.6	3.6	3.6	3.4	4.9	4.8	4.8
$T_{VDD2OUT}$	$V_{DD}$	Output available at I/O	$V_{DD}$ at its minimum threshold level to output	3096	2975	3012	2959	2869	2992	3225
$T_{VDD2POR}$	$V_{DD}$	POWER_ON_RESET_N	$V_{DD}$ at its minimum threshold level to fabric	2476	2487	2496	2486	2406	2563	2602
$T_{VDD2MSSRST}$	$V_{DD}$	MSS_RESE T_N_M2F	$V_{DD}$ at its minimum threshold level to MSS	3093	2972	3008	2956	2864	2987	3220
$T_{VDD2WPU}$	DEVRST_N	DDRIO Inbuf weak pull	DEVRST_N to Inbuf weak pull	2500	2487	2509	2475	2507	2519	2617
	DEVRST_N	MSIO Inbuf weak pull	DEVRST_N to Inbuf weak pull	2504	2491	2510	2478	2517	2525	2620
	DEVRST_N	MSIOD Inbuf weak pull	DEVRST_N to Inbuf weak pull	2479	2468	2493	2458	2486	2499	2595

**Note:** For more information about power-up times, see [UG0331: SmartFusion2 Microcontroller Subsystem User Guide](#).

The following table lists the IGLOO2 DEVRST\_N to functional times in worst-case industrial conditions when  $T_J = 100\text{ }^\circ\text{C}$ ,  $V_{DD} = 1.14\text{ V}$ .

**Table 292 • DEVRST\_N to Functional Times for IGLOO2**

Symbol	From	To	Description	Maximum Power-up to Functional Time for IGLOO2 (uS)						
				005	010	025	050	060	090	150
$T_{POR2OUT}$	POWER_ON_RESET_N	Output available at I/O	Fabric to output	114	116	113	113	115	115	114
$T_{DEVRST2OUT}$	DEVRST_N	Output available at I/O	$V_{DD}$ at its minimum threshold level to output	314	353	314	307	343	341	341
$T_{DEVRST2POR}$	DEVRST_N	POWER_ON_RESET_N	$V_{DD}$ at its minimum threshold level to fabric	200	238	201	195	230	229	227
$T_{DEVRST2WPU}$	DEVRST_N	DDRIO Inbuf weak pull	DEVRST_N to Inbuf weak pull	208	202	197	193	216	215	215
	DEVRST_N	MSIO Inbuf weak pull	DEVRST_N to Inbuf weak pull	208	202	197	193	216	215	215
	DEVRST_N	MSIOD Inbuf weak pull	DEVRST_N to Inbuf weak pull	208	202	197	193	216	215	215

**Table 293 • Flash\*Freeze Entry and Exit Times (continued)**

Parameter	Symbol	Entry/Exit Timing FCLK = 100MHz			Entry/Exit Timing FCLK = 3 MHz	
		005, 010, 025, 060, 090, and 150	050	All Devices	Unit	Conditions
Exit time with respect to the fabric PLL lock <sup>1</sup>	TFF_EXIT	1.5	1.5	1.5	ms	eNVM and MSS/HPMS PLL = ON during F*F
		1.5	1.5	1.5	ms	eNVM and MSS/HPMS PLL = OFF during F*F and both are turned back on at exit
Exit time with respect to the fabric buffer output	TFF_EXIT	21	15	21	µs	eNVM and MSS/HPMS PLL = ON during F*F
		65	55	65	µs	eNVM and MSS/HPMS PLL = OFF during F*F and both are turned back on at exit

1. PLL Lock Delay set to 1024 cycles (default).

### 2.3.28 DDR Memory Interface Characteristics

The following table lists the DDR memory interface characteristics in worst-case industrial conditions when T<sub>J</sub> = 100 °C, V<sub>DD</sub> = 1.14 V.

**Table 294 • DDR Memory Interface Characteristics**

Standard	Supported Data Rate		Unit
	Min	Max	
DDR3	667	667	Mbps
DDR2	667	667	Mbps
LPDDR	50	400	Mbps

### 2.3.29 SFP Transceiver Characteristics

IGLOO2 and SmartFusion2 SerDes complies with small form-factor pluggable (SFP) requirements as specified in SFP INF-80741. The following table provides the electrical characteristics.

The following table lists the SFP transceiver electrical characteristics in worst-case industrial conditions when T<sub>J</sub> = 100 °C, V<sub>DD</sub> = 1.14 V.

**Table 295 • SFP Transceiver Electrical Characteristics**

Pin	Direction	Differential Peak-Peak Voltage		Unit
		Min	Max	
RD+/- <sup>1</sup>	Output	1600	2400	mV
TD+/- <sup>2</sup>	Input	350	2400	mV

1. Based on default SerDes transmitter settings for PCIe Gen1. Lower amplitudes are available through programming changes to TX\_AMP setting.
2. Based on Input Voltage Common-Mode (VICM) = 0 V. Requires AC Coupling.

**Table 310 • SPI Characteristics for All Devices (continued)**

Symbol	Description	Min	Typ	Max	Unit	Conditions
SPI master configuration (applicable for 060, 090, and 150 devices)						
sp6m	SPI_[0 1]_DO setup time <sup>2</sup>	(SPI_x_CLK_period/2) – 7.0			ns	
sp7m	SPI_[0 1]_DO hold time <sup>2</sup>	(SPI_x_CLK_period/2) – 9.5			ns	
sp8m	SPI_[0 1]_DI setup time <sup>2</sup>	15			ns	
sp9m	SPI_[0 1]_DI hold time <sup>2</sup>	–2.5			ns	
SPI slave configuration (applicable for 060, 090, and 150 devices)						
sp6s	SPI_[0 1]_DO setup time <sup>2</sup>	(SPI_x_CLK_period/2) – 16.0			ns	
sp7s	SPI_[0 1]_DO hold time <sup>2</sup>	(SPI_x_CLK_period/2) – 3.5			ns	
sp8s	SPI_[0 1]_DI setup time <sup>2</sup>	3			ns	
sp9s	SPI_[0 1]_DI hold time <sup>2</sup>	2.5			ns	

1. For specific Rise/Fall Times board design considerations and detailed output buffer resistances, use the corresponding IBIS models located on the Microsemi SoC Products Group website: <http://www.microsemi.com/soc/download/ibis/default.aspx>.
2. For allowable pclk configurations, see the Serial Peripheral Interface Controller section in the *UG0331: SmartFusion2 Microcontroller Subsystem User Guide*.

**Figure 23 • SPI Timing for a Single Frame Transfer in Motorola Mode (SPH = 1)**

